

FORM PTO-1449

U.S. DEPARTMENT OF  
COMMERCE PATENT  
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ATTY. DOCKET NO.

PSU 00 2182A

APPLICANT

NATAN ET AL

FILING DATE

JUNE 20, 2000

SERIAL NO.

09/598,395

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## U.S. PATENT DOCUMENTS

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AM	AA	5,547,748	08/1998/1996	Ruoff et al.	428	323	
AM	AB	6,143,211	11/2000	Mathiowitz et al.	264	4	
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	AAA	
	AAB	
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*Arden Marsh*

DATE CONSIDERED 5-21-03

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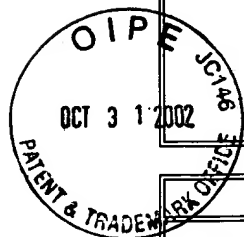
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Andin Masochel

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	AO	Al-Rawashdeh et al. (1998) J. Phys. Chem. B 102:361-371	X
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Jordan Mancoske

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Tierney